

Search Notes



Application/Control No.

10/501,744

Examiner

Sang Y. Paik

Applicant(s)/Patent under
Reexamination

KACHI ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1 444.1 390		
392	418		
118	024 725	7/24/05	SP
updated		2/12/06	2P
		9/1/06	Y
		5/16/07	X

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
First time searched	8/24/05	X